

SCES024J-JULY 1995-REVISED OCTOBER 2004

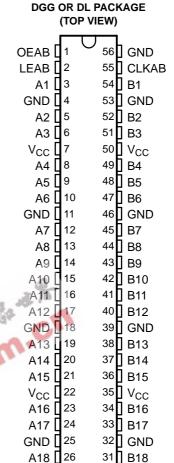
FEATURES

- Member of the Texas Instruments Widebus™
 Family
- UBT[™] Transceiver Combines D-Type Latches and D-Type Flip-Flops for Operation in Transparent, Latched, or Clocked Modes
- Operates From 1.65 V to 3.6 V
- Max t_{pd} of 3.9 ns at 3.3 V
- ±24-mA Output Drive at 3.3 V
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)

DESCRIPTION/ORDERING INFORMATION

This 18-bit universal bus transceiver is designed for 1.65-V to 3.6-V $V_{\rm CC}$ operation.

Data flow in each direction is controlled by output-enable (OEAB and OEBA), latch-enable (LEAB and LEBA), and clock (CLKAB and CLKBA) inputs. For A-to-B data flow, the device operates in the transparent mode when LEAB is high. When LEAB is low, the A data is latched if CLKAB is held at a high or low logic level. If LEAB is low, the A data is stored in the latch/flip-flop on the low-to-high transition of CLKAB. When OEAB is high, the outputs are active. When OEAB is low, the outputs are in the high-impedance state.



OEBA 27

LEBA [

28

Data flow for B to A is similar to that of A to B, but uses $\overline{\text{OEBA}}$, LEBA, and CLKBA. The output enables are complementary (OEAB is active high, and $\overline{\text{OEBA}}$ is active low).

ORDERING INFORMATION

T _A	PACKAG	iE ⁽¹⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
	SSOP - DL	Tube	SN74ALVCH16501DL	ALVCH16501	
	220h - DF	Tape and reel	SN74ALVCH16501DLR		
-40°C to 85°C	TSSOP - DGG	Tape and reel	SN74ALVCH16501DGGR	ALVCH16501	
	VFBGA - GQL	Tana and mad	SN74ALVCH16501KR	\/\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	
	VFBGA - ZQL (Pb-free)		74ALVCH16501ZQLR	VH501	

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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30 CLKBA

29 GND

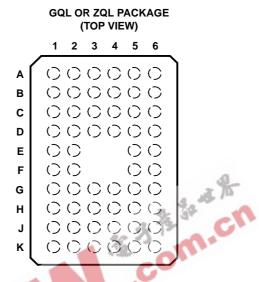




DESCRIPTION/ORDERING INFORMATION (CONTINUED)

To ensure the high-impedance state during power up or power down, $\overline{\text{OEBA}}$ should be tied to V_{CC} through a pullup resistor, and OEAB should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Active bus-hold circuitry holds unused or undriven inputs at a valid logic state. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.



TERMINAL ASSIGNMENTS

	1	2	3	4	5	6
Α	A1	LEAB	OEAB	GND	CLKAB	B1
В	A3	A2	GND	GND	B2	В3
С	A5	A4	V_{CC}	V_{CC}	B4	B5
D	A7	A6	GND	GND	B6	В7
E	A9	A8			B8	В9
F	A10	A11			B11	B10
G	A12	A13	GND	GND	B13	B12
Н	A14	A15	V_{CC}	V_{CC}	B15	B14
J	A16	A17	GND	GND	B17	B16
K	A18	OEBA	LEBA	GND	CLKBA	B18



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FUNCTION TABLE(1)

	INPUTS							
OEAB	LEAB	CLKAB	Α	В				
L	Χ	Χ	Χ	Z				
Н	Н	X	L	L				
Н	Н	X	Н	Н				
Н	L	\uparrow	L	L				
Н	L	\uparrow	Н	Н				
Н	L	Н	Χ	B ₀ ⁽²⁾				
Н	L	L	X	B ₀ ⁽²⁾ B ₀ ⁽³⁾				

- (1) A-to-B data flow is shown; B-to-A flow is similar, but uses OEBA, LEBA, and CLKBA.
- Output level before the indicated steady-state input conditions were established, provided that CLKAB was high before LEAB went low

 Output level before the indicated steady-state input conditions were
- established

LOGIC DIAGRAM (POSITIVE LOGIC) OEAB 1 CLKAB 55 LEAB 2 LEBA 28 CLKBA -OEBA 27 A1 ___ 54 B1 1D C1 > CLK 1D C1 CLK< To 17 Other Channels

Pin numbers shown are for the DGG and DL packages.

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ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{CC}	Supply voltage range		-0.5	4.6	V
.,	lanut valtana anana	Except I/O ports ⁽²⁾	-0.5	4.6	V
VI	Input voltage range	I/O ports ⁽²⁾⁽³⁾	-0.5	V _{CC} + 0.5	V
Vo	Output voltage range ⁽²⁾⁽³⁾		-0.5	V _{CC} + 0.5	V
I _{IK}	Input clamp current	V _I < 0		-50	mA
I _{OK}	Output clamp current	V _O < 0		-50	mA
Io	Continuous output current			±50	mA
	Continuous current through each V _{CC}	or GND		±100	mA
		DGG package		64	
θ_{JA}	Package thermal impedance (4)	DL package		56	°C/W
		GQL/ZQL package		42	
T _{stg}	Storage temperature range		-65	150	°C

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- (2) The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.
- (3) This value is limited to 4.6 V maximum.
- (4) The package thermal impedance is calculated in accordance with JESD 51-7.

RECOMMENDED OPERATING CONDITIONS(1)

			MIN	MAX	UNIT		
V _{CC}	Supply voltage		1.65	3.6	V		
- 00	113	V _{CC} = 1.65 V to 1.95 V	0.65 × V _{CC}				
V_{IH}	High-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7		V		
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2				
		V _{CC} = 1.65 V to 1.95 V		0.35 × V _{CC}			
V_{IL}	Low-level input voltage	V _{CC} = 2.3 V to 2.7 V		0.7	V		
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$		0.8			
V _I	Input voltage		0	V _{CC}	V		
Vo	Output voltage		0	V _{CC}	V		
		V _{CC} = 1.65 V		-4			
		V _{CC} = 2.3 V		-12	1		
ОН	High-level output current	V _{CC} = 2.7 V		-12	mA		
		V _{CC} = 3 V		-24			
		V _{CC} = 1.65 V		4			
	Laveland adapt comment	V _{CC} = 2.3 V		12	1		
l _{OL}	Low-level output current	V _{CC} = 2.7 V	12 24		mA		
		V _{CC} = 3 V					
Δt/Δν	Input transition rise or fall rate	1		10	ns/V		
T _A	Operating free-air temperature		-40	85	°C		

All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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ELECTRICAL CHARACTERISTICS

over recommended operating free-air temperature range (unless otherwise noted)

PAF	RAMETER	TEST CONDITIONS	V _{cc}	MIN	TYP ⁽¹⁾ MAX	UNIT		
		I _{OH} = -100 μA	1.65 V to 3.6 V	V _{CC} - 0.2				
		I _{OH} = -4 mA	1.65 V	1.2				
		I _{OH} = -6 mA	2.3 V	2				
V_{OH}			2.3 V	1.7		V		
		I _{OH} = -12 mA	2.7 V	2.2				
			3 V	2.4				
		I _{OH} = -24 mA	3 V	2				
		$I_{OL} = 100 \mu\text{A}$	1.65 V to 3.6 V		0.2			
V	I _{OL} = 4 mA	1.65 V		0.45				
		I _{OL} = 6 mA	2.3 V		0.4	V		
V _{OL}		1. 12.50	2.3 V		0.7			
		I _{OL} = 12 mA	2.7 V		0.4			
		I _{OL} = 24 mA	3 V		0.55			
I		$V_I = V_{CC}$ or GND	3.6 V		±5	μΑ		
		V _I = 0.58 V	1.65 V	25				
		V _I = 1.07 V	1.65 V	-25				
		V _I = 0.7 V	2.3 V	45				
I _{I(hold)}		V _I = 1.7 V	2.3 V	-45		μΑ		
		V _I = 0.8 V	3 V	75				
		V _I = 2 V	3 V	-75				
		V _I = 0 V to 3.6 V ⁽²⁾	3.6 V		±500			
I _{OZ} (3)		$V_O = V_{CC}$ or GND	3.6 V		±10	μΑ		
I _{CC}		$V_1 = V_{CC}$ or GND, $I_0 = 0$	3.6 V		40	μΑ		
ΔI_{CC}		One input at V _{CC} - 0.6 V, Other inputs at V _{CC} or GND	3 V to 3.6 V		750	μΑ		
Ci	Control inputs	$V_I = V_{CC}$ or GND	3.3 V		4	pF		
C _{io}	A or B ports	$V_O = V_{CC}$ or GND	3.3 V		8	pF		

⁽¹⁾ All typical values are at $V_{CC} = 3.3 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

TIMING REQUIREMENTS

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

	•	•	• ,	, , , , , , , , , , , , , , , , , , , ,						
					V _{CC} = 2.5 V ± 0.2 V		V _{CC} = 2.7 V		V _{CC} = 3.3 V ± 0.3 V	
				MIN	MAX	MIN	MAX	MIN	MAX	
f _{clock}	Clock frequency				150		150		150	MHz
Dalam damedian	LE high			3.3		3.3		3.3		
ι _W	t _w Pulse duration	CLK high or low	CLK high or low			3.3		3.3	3.3	ns
		Data before CLK↑		2.2		2.1		1.7		
t_{su}	Setup time	Data hafara I E	CLK high	1.9		1.6		1.5		ns
		Data before LE↓	CLK low	1.3		1.1		1		
	t _h Hold time	Hold time Data after CLK↑ Data after LE↓ CLK high or low		0.6		0.6		0.7		
τ _h				1.4		1.7		1.4		ns

⁽²⁾ This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to another

⁽³⁾ For I/O ports, the parameter I_{OZ} includes the input leakage current.





SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	TO (OUTPUT)	V _{CC} = 2 ± 0.2	V_{CC} = 2.5 V \pm 0.2 V		2.7 V	V_{CC} = 3.3 V \pm 0.3 V		UNIT	
	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX		
f _{max}			150		150		150		MHz	
	A or B	B or A	1	4.8		4.5	1	3.9		
t _{pd}	LE	A or B	1.1	5.7		5.3	1.3	4.6	ns	
	CLK	AUID	1.2	6.1		5.6	1.4	4.9		
t _{en}	OEAB	В	1	5.8		5.3	1	4.6	ns	
t _{dis}	OEAB	В	1.5	6.2		5.7	1.4	5	ns	
t _{en}	OEBA	А	1.3	6.3		6	1.1	5	ns	
t _{dis}	OEBA	A	1.3	5.3		4.6	1.3	4.2	ns	

OPERATING CHARACTERISTICS

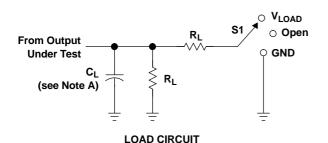
 $T_A = 25^{\circ}C$

	PARAMETER		TEST CONDITIONS	V _{CC} = 2.5 V	V _{CC} = 3.3 V TYP	UNIT
C	Power dissipation capacitance	Outputs enabled	C _L = 50 pF, f = 10 MHz	44	54	nE
C _{pd}	Fower dissipation capacitance	Outputs disabled	C _L = 50 pr, i = 10 Minz	6	6	pF
			.co.			



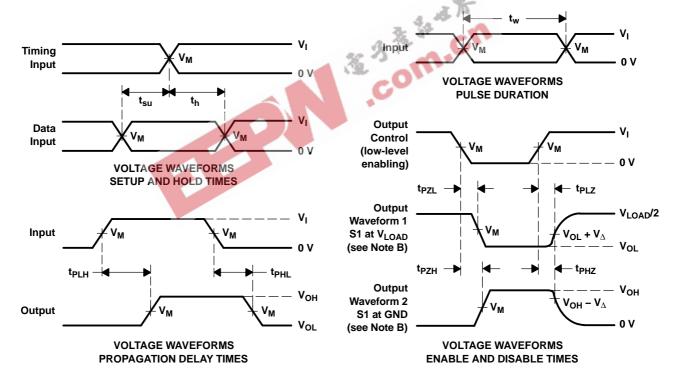


PARAMETER MEASUREMENT INFORMATION



TEST	S 1
t _{pd}	Open
t _{PLZ} /t _{PZL}	V _{LOAD}
t _{PHZ} /t _{PZH}	GND

,	INPUT		, , , , , , , , , , , , , , , , , , ,	V		В	V
V _{CC}	V _I	t _r /t _f	V _M	V _{LOAD}	CL	R_L	V_{Δ}
1.8 V	V _{CC}	≤2 ns	V _{CC} /2	2×V _{CC}	30 pF	1 k Ω	0.15 V
2.5 V \pm 0.2 V	v _{cc}	≤ 2 ns	V _{CC} /2	$2 \times V_{CC}$	30 pF	500 Ω	0.15 V
2.7 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V
3.3 V \pm 0.3 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_{O} = 50 Ω
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis}.
- F. t_{PZL} and t_{PZH} are the same as t_{en}.
- G. t_{PLH} and t_{PHL} are the same as t_{pd} .
- H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms



PACKAGE OPTION ADDENDUM

6-Dec-2006

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
74ALVCH16501DGGRG4	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ALVCH16501DLG4	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ALVCH16501DLRG4	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ALVCH16501ZQLR	ACTIVE	BGA MI CROSTA R JUNI OR	ZQL	56	1000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM
SN74ALVCH16501DGGR	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALVCH16501DL	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALVCH16501DLR	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALVCH16501KR	ACTIVE	BGA MI CROSTA R JUNI OR	GQL	56	1000	TBD T	SNPB	Level-1-240C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

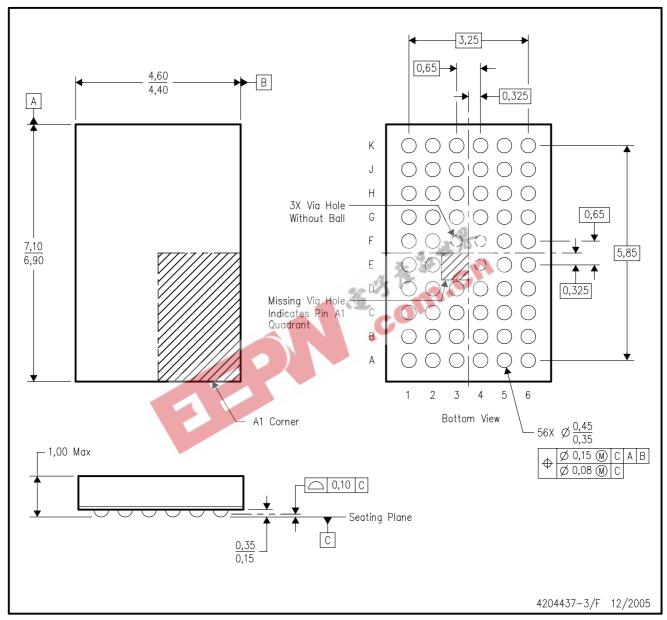
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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ZQL (R-PBGA-N56)

PLASTIC BALL GRID ARRAY



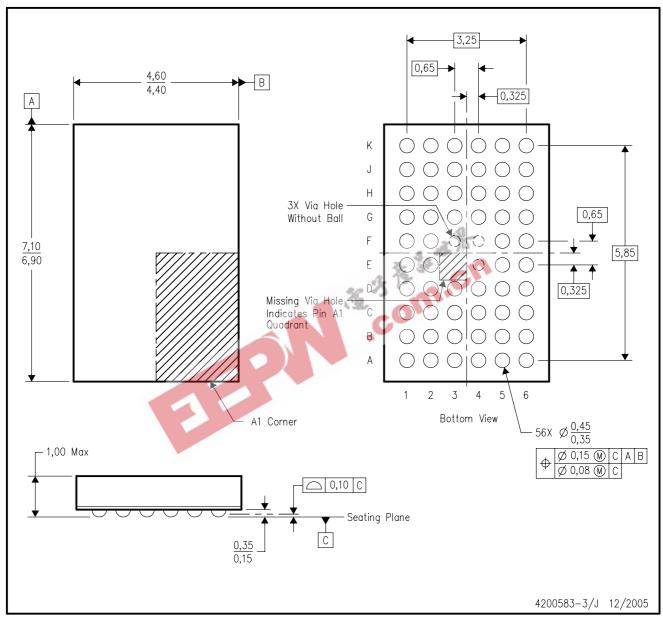
NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-225 variation BA.
- D. This package is lead-free. Refer to the 56 GQL package (drawing 4200583) for tin-lead (SnPb).



GQL (R-PBGA-N56)

PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

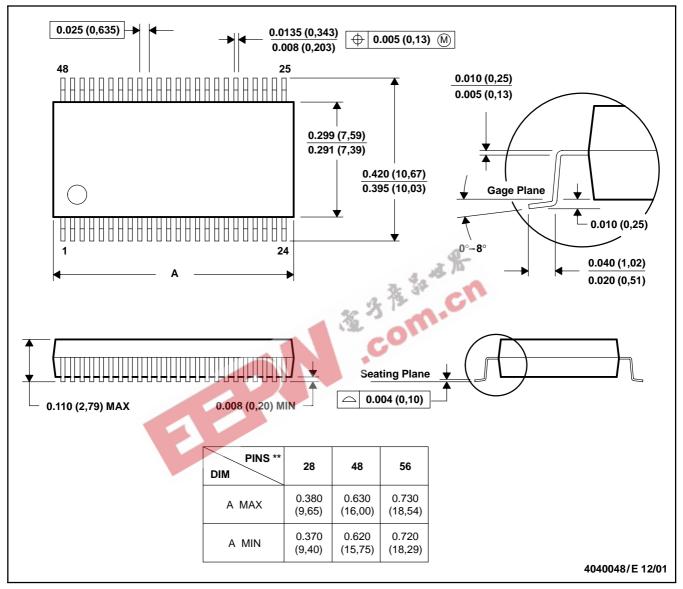
- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-225 variation BA.
- D. This package is tin-lead (SnPb). Refer to the 56 ZQL package (drawing 4204437) for lead-free.



DL (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



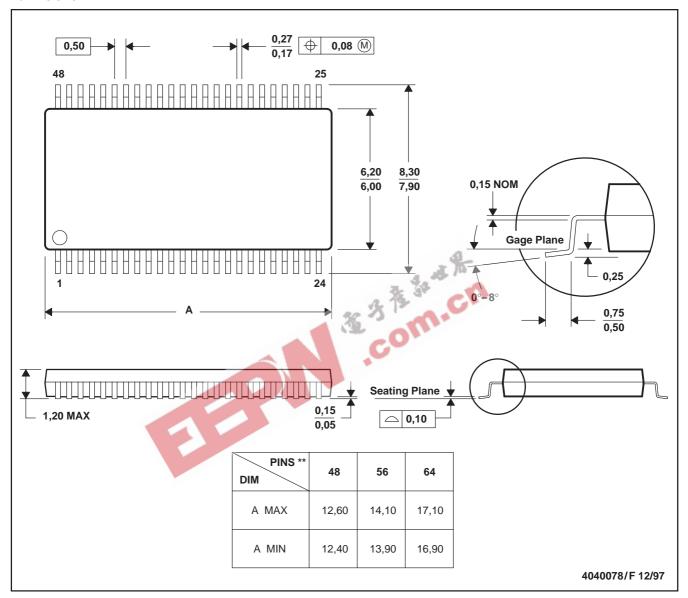
NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MO-118

DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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